

<b>Notice of References Cited</b>	Application/Control No. 09/886,064	Applicant(s)/Patent Under Reexamination HAITSMA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,332,194	12-2001	Bloom et al.	713/176
*	B	US-6,216,228	04-2001	Chapman et al.	713/176
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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